

**Notice of References Cited**

Application/Control No.

09/711,504

Applicant(s)/Patent Under  
Reexamination  
KATOH ET AL.

Examiner

A. Sefer

Art Unit

2826

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,818,070	10-1998	Yamazaki et al	257/72
	B	US-5,965,916	10-1999	Chen	257/347
	C	US-6,087,730	07-2000	McGarvey et al	257/766
	D	US-5,567,959	10-1996	Meneji	257/69
	E	US-2002/0139978	10-2002	Yamazaki et al	257/69
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10-290012 ✓	10-1998	Japan	Sakurai	
	O	JP 6-230425 ✓	08-1994	Japan	Miyajima	
	P	JP 2000-196093	07-2000	Japan	Yamazaki et al	
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.